

Notice of References Cited	Application/Control No. 10/713,539	Applicant(s)/Patent Under Reexamination TOYAMA ET AL.	
	Examiner Kimbhinh T. Nguyen	Art Unit 2628	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,888,552	05-2005	Debevec et al.	345/589
*	B	US-7,010,174	03-2006	Kang et al.	382/274
	C	US-			
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	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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